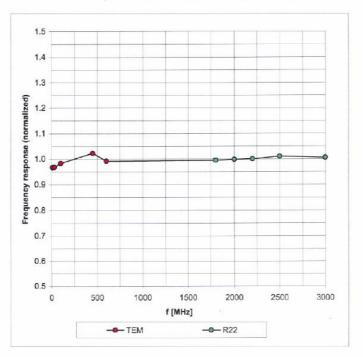
ET3DV6 SN:1788

September 30, 2004

# Frequency Response of E-Field

(TEM-Cell:ifi110 EXX, Waveguide: R22)



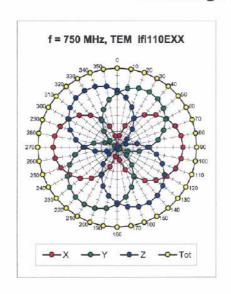
Uncertainty of Frequency Response of E-field: ± 6.3% (k=2)

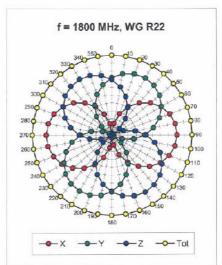
Certificate No: ET3-1788\_Sep04

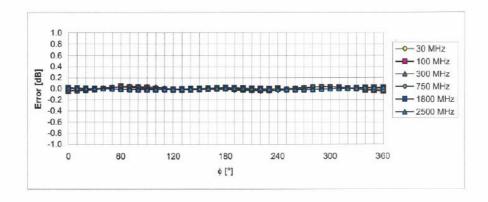
#### ET3DV6 SN:1788

September 30, 2004

# Receiving Pattern ( $\phi$ ), $\vartheta = 0^{\circ}$







Uncertainty of Axial Isotropy Assessment: ± 0.5% (k=2)

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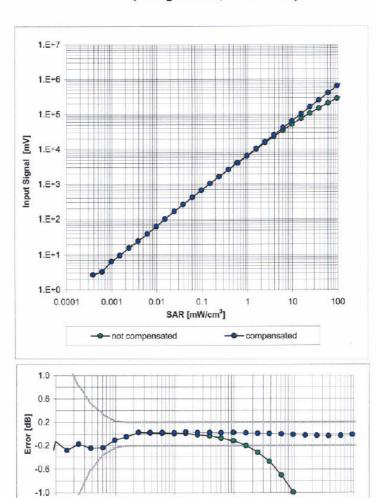
Page 6 of 9

### ET3DV6 SN:1788

September 30, 2004

# Dynamic Range f(SAR<sub>head</sub>)

(Waveguide R22, f = 1800 MHz)



Uncertainty of Linearity Assessment: ± 0.6% (k=2)

SAR [mW/cm<sup>3</sup>]

10

100

Certificate No: ET3-1788\_Sep04

0.001

Page 7 of 9

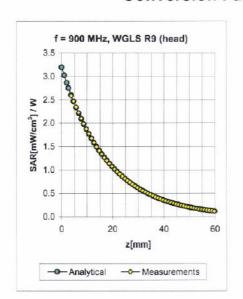
0.01

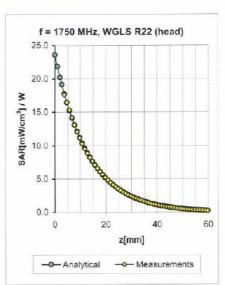
CC SAR TEST REPORT Test Report No : FA551807-04-1-2-01

ET3DV6 SN:1788

September 30, 2004

# **Conversion Factor Assessment**





f [MHz]	Validity [MHz] <sup>C</sup>	TSL	Permittivity	Conductivity	Alpha	Depth	ConvF Uncertainty
835	± 50 / ± 100	Head	41.5 ± 5%	0.90 ± 5%	1.12	1.42	6.74 ± 11.0% (k=2)
900	$\pm 50 / \pm 100$	Head	$41.5\pm5\%$	0.97 ± 5%	1.07	1.44	6.63 ± 11.0% (k=2)
1750	$\pm 50 / \pm 100$	Head	$40.0 \pm 5\%$	1.40 ± 5%	0.56	2.31	5.37 ± 11.0% (k=2)
1900	± 50 / ± 100	Head	$40.0\pm5\%$	1.40 ± 5%	0.55	2.42	5.16 ± 11.0% (k=2)
2000	± 50 / ± 100	Head	$40.0 \pm 5\%$	1.40 ± 5%	0.54	2.59	4.88 ± 11.0% (k=2)
2450	± 50 / ± 100	Head	$39.2\pm5\%$	1.80 ± 5%	0.65	2.22	4.56 ± 11.8% (k=2)
835	± 50 / ± 100	Body	55.2 ± 5%	0.97 ± 5%	1.04	1.52	6.53 ± 11.0% (k=2)
900	± 50 / ± 100	Body	55.0 ± 5%	1.05 ± 5%	0.99	1.56	6.17 ± 11.0% (k=2)
1750	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.53	2.74	4.73 ± 11.0% (k=2)
1900	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.55	2.82	4.56 ± 11.0% (k=2)
2000	± 50 / ± 100	Body	53.3 ± 5%	1.52 ± 5%	0.54	2.98	4.43 ± 11.0% (k=2)
2450	± 50 / ± 100	Body	52.7 ± 5%	1.95 ± 5%	0.72	2.00	4.26 ± 11.8% (k=2)

 $<sup>^{\</sup>rm C}$  The validity of  $\pm$  100 MHz only applies for DASY 4.3 B17 and higher (see Page 2). The uncertainty is the RSS of the ConvF uncertainty at calibration frequency and the uncertainty for the indicated frequency band.

Certificate No: ET3-1788\_Sep04

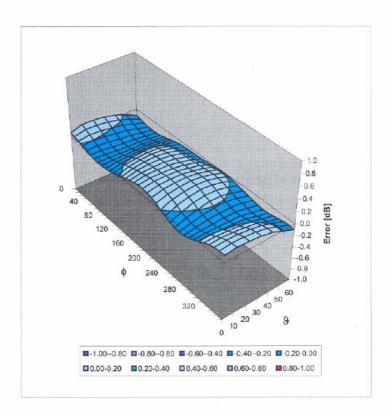
Page 8 of 9

ET3DV6 SN:1788

September 30, 2004

# **Deviation from Isotropy in HSL**

Error (4, 3), f = 900 MHz



Uncertainty of Spherical Isotropy Assessment: ± 2.6% (k=2)

Certificate No: ET3-1788\_Sep04

Page 9 of 9



# FCC SAR TEST REPORT

Test Report No : FA551807-04-1-2-01

Calibration Laboratory of Schmid & Partner

Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



Schweizerischer Kalibrierdienst Service suisse d'étalonnage Servizio svizzero di taratura Swiss Calibration Service

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Sporton (Auden)

Accreditation No.: SCS 108

S

C

Certificate No: DAE3-577\_Nov04 CALIBRATION CERTIFICATE Object DAE3 - SD 000 D03 AA - SN: 577 QA CAL-06.v10 Calibration procedure(s) Calibration procedure for the data acquisition unit (DAE) November 17, 2004 Calibration date: Condition of the calibrated item In Tolerance This calibration certificate documents the traceability to national standards, which realize the physical units of measurements (SI). The measurements and the uncertainties with confidence probability are given on the following pages and are part of the certificate. All calibrations have been conducted in the closed laboratory facility; environment temperature (22 ± 3)°C and humidity < 70%. Calibration Equipment used (M&TE critical for calibration) Primary Standards ID# Cal Date (Calibrated by, Certificate No.) Scheduled Calibration Fluke Process Calibrator Type 702 SN: 6295803 7-Sep-04 (Sintrel, No.E-040073) Sep-05 ID# Secondary Standards Check Date (in house) Scheduled Check Calibrator Box V1.1 SE UMS 006 AB 1002 16-Jul-04 (SPEAG, in house check) In house check Jul-05 Eric Hainfeld Calibrated by: Technician Fin Bomholt R&D Director Approved by: Issued: November 17, 2004 This calibration certificate shall not be reproduced except in full without written approval of the laboratory.

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Page 1 of 5

#### Calibration Laboratory of

Schmid & Partner Engineering AG Zeughausstrasse 43, 8004 Zurich, Switzerland



S Schweizerischer Kalibrierdienst
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S Swiss Calibration Service

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Accredited by the Swiss Federal Office of Metrology and Accreditation The Swiss Accreditation Service is one of the signatories to the EA Multilateral Agreement for the recognition of calibration certificates

#### Glossary

DAE digital acquisition electronics

Connector angle information used in DASY system to align probe sensor X to the robot

coordinate system.

#### Methods Applied and Interpretation of Parameters

- DC Voltage Measurement: Calibration Factor assessed for use in DASY system by comparison with a calibrated instrument traceable to national standards. The figure given corresponds to the full scale range of the voltmeter in the respective range.
- Connector angle: The angle of the connector is assessed measuring the angle mechanically by a tool inserted. Uncertainty is not required.
- The following parameters contain technical information as a result from the performance test and require no uncertainty.
- DC Voltage Measurement Linearity: Verification of the Linearity at +10% and -10% of the nominal calibration voltage. Influence of offset voltage is included in this measurement.
- Common mode sensitivity: Influence of a positive or negative common mode voltage on the differential measurement.
- Channel separation: Influence of a voltage on the neighbor channels not subject to an input voltage.
- AD Converter Values with inputs shorted: Values on the internal AD converter corresponding to zero input voltage
- Input Offset Measurement: Output voltage and statistical results over a large number of zero voltage measurements.
- Input Offset Current: Typical value for information; Maximum channel input offset current, not considering the input resistance.
- Input resistance: DAE input resistance at the connector, during internal auto-zeroing and during measurement.
- Low Battery Alarm Voltage: Typical value for information. Below this voltage, a battery alarm signal is generated.
- Power consumption: Typical value for information. Supply currents in various operating modes.

Certificate No: DAE3-577\_Nov04

Page 2 of 5

#### DC Voltage Measurement

A/D - Converter Resolution nominal

High Range: Low Range:

 $\begin{array}{lll} \mbox{1LSB} = & 6.1 \mu \mbox{V} \,, & \mbox{full range} = & -100...+300 \mbox{ mV} \\ \mbox{1LSB} = & 61 \mbox{nV} \,, & \mbox{full range} = & -1......+3 \mbox{mV} \end{array}$ 

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

Calibration Factors	х	Y	z
High Range	404.437 ± 0.1% (k=2)	403.891 ± 0.1% (k=2)	404.359 ± 0.1% (k=2)
Low Range	3.94121 ± 0.7% (k=2)	3.89867 ± 0.7% (k=2)	3.95408 ± 0.7% (k=2)

# **Connector Angle**

Connector Angle to be used in DASY system	127°±1°
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Certificate No: DAE3-577\_Nov04

Page 3 of 5

# Appendix

1. DC Voltage Linearity

High Range	Input (μV)	Reading (μV)	Error (%)
Channel X + Input	200000	200000.6	0.00
Channel X + Input	20000	20001.77	0.01
Channel X - Input	20000	-19991.81	-0.04
Channel Y + Input	200000	199999.7	0.00
Channel Y + Input	20000	19999.20	0.00
Channel Y - Input	20000	-19994.82	-0.03
Channel Z + Input	200000	200000.2	0.00
Channel Z + Input	20000	19996.22	-0.02
Channel Z - Input	20000	-19996.74	-0.02

Low Range	Input (μV)	Reading (μV)	Error (%)
Channel X + Input	2000	2000	0.00
Channel X + Input	200	200.05	0.03
Channel X - Input	200	-200.88	0.44
Channel Y + Input	2000	1999.9	0.00
Channel Y + Input	200	199.73	-0.13
Channel Y - Input	200	-200.53	0.27
Channel Z + Input	2000	2000.1	0.00
Channel Z + Input	200	199.25	-0.38
Channel Z - Input	200	-201.42	0.71

# 2. Common mode sensitivity

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Common mode Input Voltage (mV)	High Range Average Reading (μV)	Low Range Average Reading (μV)
Channel X	200	13.15	12.30
	- 200	-12.61	-12.86
Channel Y	200	-7.43	-7.53
	- 200	6.30	6.52
Channel Z	200	-0.16	0.31
	- 200	-1.51	-1.48

### 3. Channel separation

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	Input Voltage (mV)	Channel X (μV)	Channel Y (μV)	Channel Z (μV)
Channel X	200	-	1.90	-0.22
Channel Y	200	1.47	-	4.60
Channel Z	200	-1.40	-0.08	

Certificate No: DAE3-577\_Nov04

Page 4 of 5

## 4. AD-Converter Values with inputs shorted

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

	High Range (LSB)	Low Range (LSB)
Channel X	15948	15814
Channel Y	15960	16073
Channel Z	16236	16172

### 5. Input Offset Measurement

DASY measurement parameters: Auto Zero Time: 3 sec; Measuring time: 3 sec

nout 10MO

	Average (μV)	min. Offset (μV)	max. Offset (μV)	Std. Deviation (µV)
Channel X	0.03	-3.07	1.24	0.58
Channel Y	-0.66	-2.19	1.96	0.55
Channel Z	-0.91	-2.82	0.42	0.39

### 6. Input Offset Current

Nominal Input circuitry offset current on all channels: <25fA

7. Input Resistance

	Zeroing (MOhm)	Measuring (MOhm)
Channel X	0.2000	199.3
Channel Y	0.2000	200.4
Channel Z	0.2001	199.5

8. Low Battery Alarm Voltage (verified during pre test)

Typical values	Alarm Level (VDC)	
Supply (+ Vcc)	+7.9	
Supply (- Vcc)	-7.6	

9. Power Consumption (verified during pre test)

Typical values	Switched off (mA)	Stand by (mA)	Transmitting (mA)
Supply (+ Vcc)	+0.0	+6	+14
Supply (- Vcc)	-0.01	-8	-9

10. Common Mode Bit Generation (verified during pre test)

Typical values	Bit set to High at Common Mode Error (V <sub>DC</sub> )
Channel X, Y, Z	+1.25

Certificate No: DAE3-577\_Nov04

Page 5 of 5